

**Product data sheet** 

## 1. Product profile

## 1.1 General description

NPN silicon RF transistor for high speed, low noise applications in a plastic, 3-pin SOT23 package.

The BFU550A is part of the BFU5 family of transistors, suitable for small signal to medium power applications up to 2 GHz.

#### 1.2 Features and benefits

- Low noise, high breakdown RF transistor
- AEC-Q101 qualified
- Minimum noise figure (NF<sub>min</sub>) = 0.6 dB at 900 MHz
- Maximum stable gain 18 dB at 900 MHz
- 11 GHz f<sub>T</sub> silicon technology

## 1.3 Applications

- Applications requiring high supply voltages and high breakdown voltages
- Broadband amplifiers up to 2 GHz
- Low noise amplifiers for ISM applications
- ISM band oscillators

#### 1.4 Quick reference data

Table 1. Quick reference data

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{CB}$	collector-base voltage	open emitter		-	-	24	V
V <sub>CE</sub>	collector-emitter voltage	open base		-	-	12	V
		shorted base		-	-	24	V
$V_{EB}$	emitter-base voltage	open collector		-	-	2	V
I <sub>C</sub>	collector current			-	15	50	mΑ
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> ≤ 87 °C	<u>[1]</u>	-	-	450	mW
h <sub>FE</sub>	DC current gain	$I_C = 15 \text{ mA}; V_{CE} = 8 \text{ V}$		60	95	200	
C <sub>c</sub>	collector capacitance	$V_{CB} = 8 \text{ V}; f = 1 \text{ MHz}$		-	0.74	-	pF
f <sub>T</sub>	transition frequency	$I_C = 25 \text{ mA}$ ; $V_{CE} = 8 \text{ V}$ ; $f = 900 \text{ MHz}$		-	11	-	GHz



#### NPN wideband silicon RF transistor

Table 1. Quick reference data ...continued

T<sub>amb</sub> = 25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$G_{p(max)}$	maximum power gain	$I_C = 15 \text{ mA}; V_{CE} = 8 \text{ V}; f = 900 \text{ MHz}$	[2] -	18	-	dB
$NF_{min}$	minimum noise figure	$I_C$ = 1 mA; $V_{CE}$ = 8 V; f = 900 MHz; $\Gamma_S$ = $\Gamma_{opt}$	-	0.6	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	$I_{C}$ = 25 mA; $V_{CE}$ = 8 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$ ; f = 900 MHz	-	13.5	-	dBm

- [1]  $T_{sp}$  is the temperature at the solder point of the collector lead.
- [2] If K > 1 then  $G_{p(max)}$  is the maximum power gain. If K < 1 then  $G_{p(max)} = MSG$ .

# 2. Pinning information

Table 2. Discrete pinning

Table 2.	Discrete piliting		
Pin	Description	Simplified outline	Graphic symbol
1	base		•
2	emitter	3	<u> </u>
3	collector		1—
		1	2 aaa-010458

# 3. Ordering information

Table 3. Ordering information

Type number	Packag	Package				
	Name Description		Version			
BFU550A	-	plastic surface-mounted package; 3 leads	SOT23			
OM7961	-	Customer evaluation kit for BFU520A, BFU530A and BFU550A [1]	-			

- [1] The customer evaluation kit contains the following:
  - a) Unpopulated RF amplifier Printed-Circuit Board (PCB)
  - b) Unpopulated RF amplifier Printed-Circuit Board (PCB) with emitter degeneration
  - c) Four SMA connectors for fitting unpopulated Printed-Circuit Board (PCB)
  - d) BFU520A, BFU530A and BFU550A samples
  - e) USB stick with data sheets, application notes, models, S-parameter and noise files

## 4. Marking

Table 4. Marking

Type number	Marking	Description		
BFU550A		* = t : made in Malaysia		
		* = w : made in China		

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# 5. Design support

Table 5. Available design support

Download from the BFU550A product information page on http://www.nxp.com.

		<del>_</del>
Support item	Available	Remarks
Device models for Agilent EEsof EDA ADS	yes	Based on Mextram device model.
SPICE model	yes	Based on Gummel-Poon device model.
S-parameters	yes	
Noise parameters	yes	
Customer evaluation kit	yes	See Section 3 and Section 10.
Solder pattern	yes	
Application notes	yes	See Section 10.1 and Section 10.2.

# 6. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CB}$	collector-base voltage	open emitter	-	30	V
$V_{CE}$	collector-emitter voltage	open base	-	16	V
		shorted base	-	30	V
$V_{EB}$	emitter-base voltage	open collector	-	3	V
I <sub>C</sub>	collector current		-	80	mΑ
T <sub>stg</sub>	storage temperature		-65	+150	°C
$V_{ESD}$	electrostatic discharge voltage	Human Body Model (HBM) According to JEDEC standard 22-A114E	-	±150	V
		Charged Device Model (CDM) According to JEDEC standard 22-C101B	-	±2	kV

# 7. Recommended operating conditions

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CB}$	collector-base voltage	open emitter	-	-	24	V
V <sub>CE</sub>	collector-emitter voltage	open base	-	-	12	V
		shorted base	-	-	24	V
V <sub>EB</sub>	emitter-base voltage	open collector	-	-	2	V
I <sub>C</sub>	collector current		-	-	50	mA
Pi	input power	$Z_S = 50 \Omega$	-	-	10	dBm
Tj	junction temperature		-40	-	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{sp} \le 87  ^{\circ}C$	<u>[1]</u> -	-	450	mW

<sup>[1]</sup>  $T_{sp}$  is the temperature at the solder point of the collector lead.

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## 8. Thermal characteristics

Table 8. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		[ <u>1]</u> 140	K/W

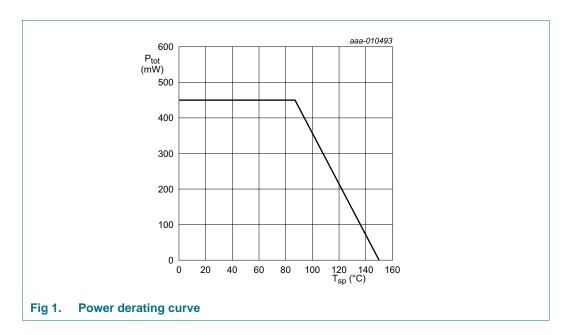
[1]  $T_{sp}$  is the temperature at the solder point of the collector lead.

 $T_{sp}$  has the following relation to the ambient temperature  $T_{amb}\!:$ 

 $T_{sp} = T_{amb} + P \times R_{th(sp-a)}$ 

With P being the power dissipation and  $R_{th(sp-a)}$  being the thermal resistance between the solder point and ambient.  $R_{th(sp-a)}$  is determined by the heat transfer properties in the application.

The heat transfer properties are set by the application board materials, the board layout and the environment e.g. housing.



### 9. Characteristics

Table 9. Characteristics

 $T_{amb} = 25 \, ^{\circ}\text{C}$  unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 100 \text{ nA}; I_E = 0 \text{ mA}$	24	-	-	V
$V_{(BR)CEO}$	collector-emitter breakdown voltage	$I_C = 150 \text{ nA}; I_B = 0 \text{ mA}$	12	-	-	V
I <sub>C</sub>	collector current		-	15	50	mΑ
$I_{CBO}$	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	<1	-	nΑ
h <sub>FE</sub>	DC current gain	$I_C = 15 \text{ mA}; V_{CE} = 8 \text{ V}$	60	95	200	
C <sub>e</sub>	emitter capacitance	$V_{EB} = 0.5 \text{ V}; f = 1 \text{ MHz}$	-	0.98	-	pF
$C_{re}$	feedback capacitance	$V_{CE} = 8 \text{ V}; f = 1 \text{ MHz}$	-	0.48	-	pF
C <sub>c</sub>	collector capacitance	$V_{CB} = 8 \text{ V}; f = 1 \text{ MHz}$	-	0.74	-	pF
$f_{T}$	transition frequency	$I_C = 25 \text{ mA}$ ; $V_{CE} = 8 \text{ V}$ ; $f = 900 \text{ MHz}$	-	11	-	GHz

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### NPN wideband silicon RF transistor

Table 9. Characteristics ... continued  $T_{amb} = 25$  °C unless otherwise specified

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
G <sub>p(max)</sub>	maximum power gain	$f = 433 \text{ MHz}; V_{CE} = 8 \text{ V}$	<u>[1]</u>				
		I <sub>C</sub> = 1 mA		-	15	-	dB
		I <sub>C</sub> = 15 mA		-	23.5	-	dB
		I <sub>C</sub> = 25 mA		-	24	-	dB
		f = 900 MHz; V <sub>CE</sub> = 8 V	<u>[1]</u>				
		I <sub>C</sub> = 1 mA		-	12.5	-	dB
		I <sub>C</sub> = 15 mA		-	18	-	dB
		I <sub>C</sub> = 25 mA		-	18	-	dB
		f = 1800 MHz; V <sub>CE</sub> = 8 V	<u>[1]</u>				
		I <sub>C</sub> = 1 mA		-	10.5	-	dB
		I <sub>C</sub> = 15 mA		-	12	-	dB
		I <sub>C</sub> = 25 mA		-	12	-	dB
$ s_{21} ^2$	insertion power gain	$f = 433 \text{ MHz}; V_{CE} = 8 \text{ V}$					
		I <sub>C</sub> = 1 mA		-	10	-	dB
		I <sub>C</sub> = 15 mA		-	21	-	dB
		I <sub>C</sub> = 25 mA		-	21.5	-	dB
		f = 900 MHz; V <sub>CE</sub> = 8 V					
		I <sub>C</sub> = 1 mA		-	8.5	-	dB
		I <sub>C</sub> = 15 mA		-	15.5	-	dB
		I <sub>C</sub> = 25 mA		-	15.5	-	dB
		f = 1800 MHz; V <sub>CE</sub> = 8 V					
		I <sub>C</sub> = 1 mA		-	5	-	dB
		I <sub>C</sub> = 15 mA		-	10	-	dB
		I <sub>C</sub> = 25 mA		-	10	-	dB
NF <sub>min</sub>	minimum noise figure	f = 433 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$					
		I <sub>C</sub> = 1 mA		-	0.5	-	dB
		I <sub>C</sub> = 15 mA		-	0.9	-	dB
		I <sub>C</sub> = 25 mA		-	1.2	-	dB
		f = 900 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$					
		I <sub>C</sub> = 1 mA		-	0.6	-	dB
		I <sub>C</sub> = 15 mA		-	1.0	-	dB
		I <sub>C</sub> = 25 mA		-	1.3	-	dB
		f = 1800 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$					
		I <sub>C</sub> = 1 mA		-	0.7	-	dB
		I <sub>C</sub> = 15 mA		-	1.1	-	dB
		I <sub>C</sub> = 25 mA		_	1.4	_	dB

#### **NPN** wideband silicon RF transistor

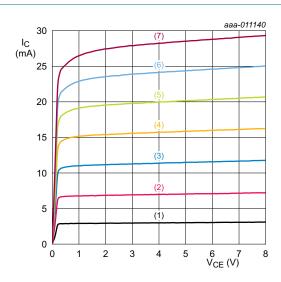
**Table 9. Characteristics** ...continued  $T_{amb} = 25$  °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
G <sub>ass</sub>	associated gain	f = 433 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$				
		I <sub>C</sub> = 1 mA	-	22	-	dB
		I <sub>C</sub> = 15 mA	-	22	-	dB
		I <sub>C</sub> = 25 mA	-	22	-	dB
		f = 900 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$				
		I <sub>C</sub> = 1 mA	-	14.5	-	dB
		I <sub>C</sub> = 15 mA	-	16	-	dB
		I <sub>C</sub> = 25 mA	-	16	-	dB
		f = 1800 MHz; $V_{CE}$ = 8 V; $\Gamma_{S}$ = $\Gamma_{opt}$				
		I <sub>C</sub> = 1 mA	-	8	-	dB
		I <sub>C</sub> = 15 mA	-	10.5	-	dB
		I <sub>C</sub> = 25 mA	-	10	-	dB
P <sub>L(1dB)</sub>	output power at 1 dB gain compression	f = 433 MHz; $V_{CE}$ = 8 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	10	-	dBm
		I <sub>C</sub> = 25 mA	-	13	-	dBm
		f = 900 MHz; $V_{CE}$ = 8 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	10.5	-	dBm
		I <sub>C</sub> = 25 mA	-	13.5	-	dBm
		f = 1800 MHz; $V_{CE}$ = 8 V; $Z_{S}$ = $Z_{L}$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	11	-	dBm
		I <sub>C</sub> = 25 mA	-	13	-	dBm
IP3 <sub>o</sub>	output third-order intercept point	$f_1$ = 433 MHz; $f_2$ = 434 MHz; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	20	-	dBm
		I <sub>C</sub> = 25 mA	-	23	-	dBm
		$f_1$ = 900 MHz; $f_2$ = 901 MHz; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	20	-	dBm
		I <sub>C</sub> = 25 mA	-	23	-	dBm
		$f_1$ = 1800 MHz; $f_2$ = 1801 MHz; $V_{CE}$ = 8 V; $Z_S$ = $Z_L$ = 50 $\Omega$				
		I <sub>C</sub> = 15 mA	-	21	-	dBm
		I <sub>C</sub> = 25 mA	-	23	-	dBm

<sup>[1]</sup> If K > 1 then  $G_{p(max)}$  is the maximum power gain. If K < 1 then  $G_{p(max)} = MSG$ .

#### NPN wideband silicon RF transistor

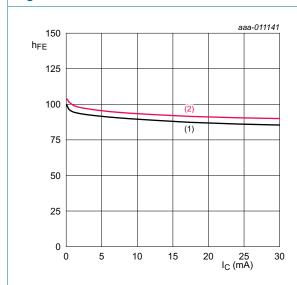
## 9.1 Graphs



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $I_B = 25 \mu A$
- (2)  $I_B = 75 \mu A$
- (3)  $I_B = 125 \mu A$
- (4)  $I_B = 175 \mu A$
- (5)  $I_B = 225 \mu A$
- (6)  $I_B = 275 \mu A$
- (7)  $I_B = 325 \mu A$

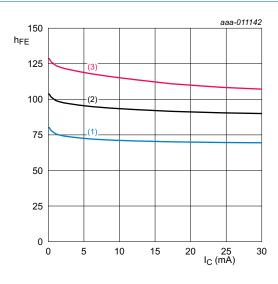
Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

Fig 3. DC current gain as function of collector current; typical values



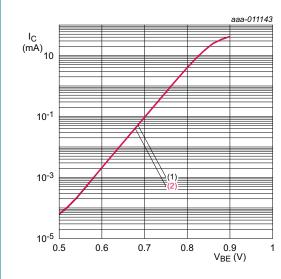
 $V_{CE} = 8 V.$ 

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = +25 \, ^{\circ}C$
- (3)  $T_{amb} = +125 \, ^{\circ}C$

Fig 4. DC current gain as function of collector current; typical values

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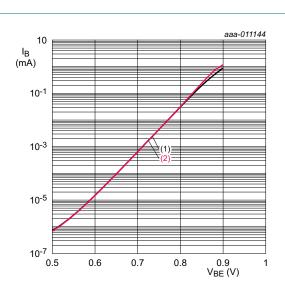
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 $T_{amb}$  = 25 °C.

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

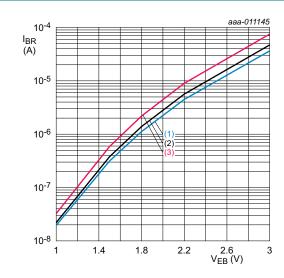
Fig 5. Collector current as a function of base-emitter voltage; typical values



 $T_{amb} = 25 \, ^{\circ}C$ .

- (1)  $V_{CE} = 3.0 \text{ V}$
- (2)  $V_{CE} = 8.0 \text{ V}$

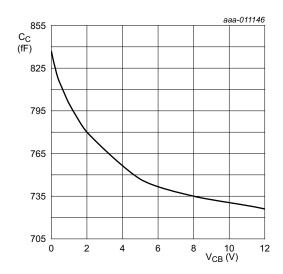
Fig 6. Base current as a function of base-emitter voltage; typical values



V<sub>CE</sub> = 3 V.

- (1)  $T_{amb} = -40 \, ^{\circ}C$
- (2)  $T_{amb} = +25 \, ^{\circ}C$
- (3)  $T_{amb} = +125 \, ^{\circ}C$

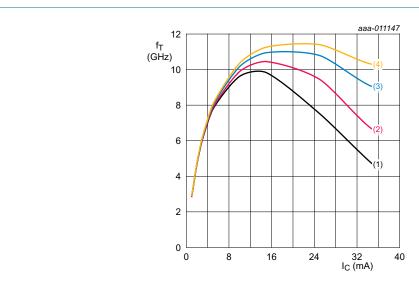
Fig 7. Reverse base current as a function of emitter-base voltage; typical values



 $I_C = 0$  mA; f = 1 MHz;  $T_{amb} = 25$  °C.

Fig 8. Collector capacitance as a function of collector-base voltage; typical values

#### NPN wideband silicon RF transistor



 $T_{amb} = 25 \, ^{\circ}C.$ 

- (1)  $V_{CE} = 3.3 \text{ V}$
- (2)  $V_{CE} = 5.0 \text{ V}$
- (3)  $V_{CE} = 8.0 \text{ V}$
- (4)  $V_{CE} = 12.0 \text{ V}$

Fig 9. Transition frequency as a function of collector current; typical values

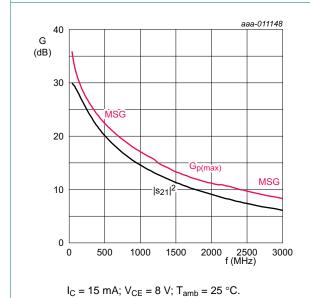
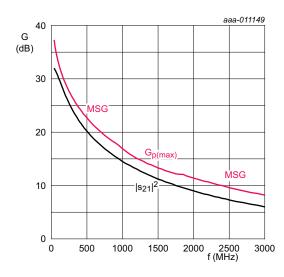


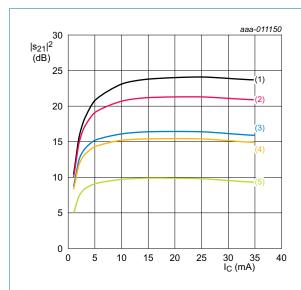
Fig 10. Gain as a function of frequency; typical values



 $I_C$  = 25 mA;  $V_{CE}$  = 8 V;  $T_{amb}$  = 25 °C.

Fig 11. Gain as a function of frequency; typical values

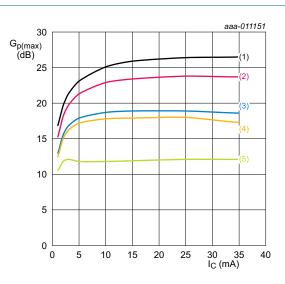
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 $V_{CE} = 8 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$ 

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz





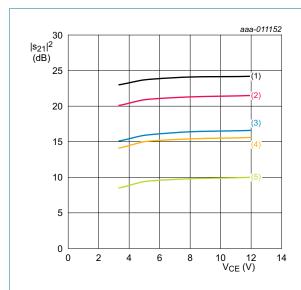
 $V_{CE}$  = 8 V;  $T_{amb}$  = 25 °C.

If K >1 then  $G_{p(max)}$  = maximum power gain. If K < 1 then  $G_{p(max)}$  = MSG.

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz

Fig 13. Maximum power gain as a function of collector current; typical values

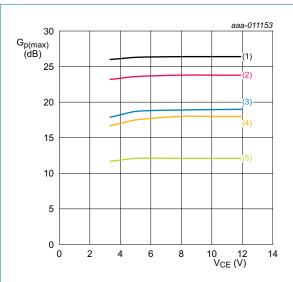
#### NPN wideband silicon RF transistor



 $I_C$  = 25 mA;  $T_{amb}$  = 25 °C.

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz

Fig 14. Insertion power gain as a function of collector-emitter voltage; typical values



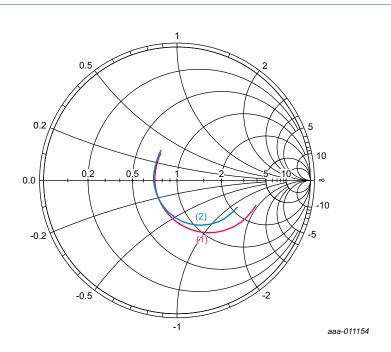
 $I_C$  = 25 mA;  $T_{amb}$  = 25 °C.

If K >1 then  $G_{p(max)}$  = maximum power gain. If K < 1 then  $G_{p(max)}$  = MSG.

- (1) f = 300 MHz
- (2) f = 433 MHz
- (3) f = 800 MHz
- (4) f = 900 MHz
- (5) f = 1800 MHz

Fig 15. Maximum power gain as a function of collector-emitter voltage; typical values

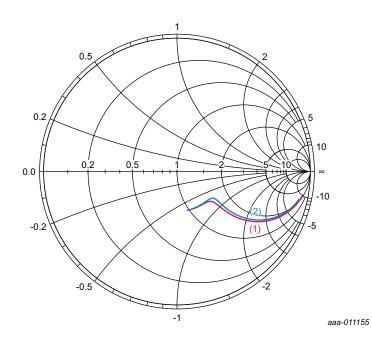
#### **NPN** wideband silicon RF transistor



 $V_{CE}$  = 8 V; 40 MHz  $\leq$  f  $\leq$  3 GHz.

- (1)  $I_C = 15 \text{ mA}$
- (2)  $I_C = 25 \text{ mA}$

Fig 16. Input reflection coefficient (s<sub>11</sub>); typical values



 $V_{CE}$  = 8 V; 40 MHz  $\leq$  f  $\leq$  3 GHz.

- (1)  $I_C = 15 \text{ mA}$
- (2)  $I_C = 25 \text{ mA}$

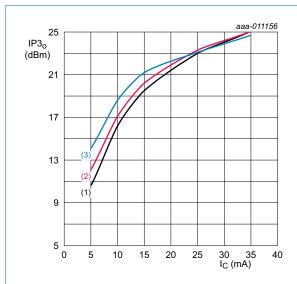
Fig 17. Output reflection coefficient  $(s_{22})$ ; typical values

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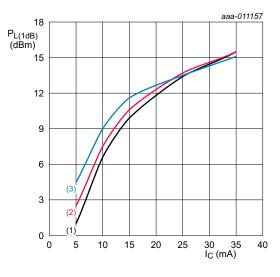
#### NPN wideband silicon RF transistor



 $V_{CE} = 8 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}.$ 

- (1)  $f_1 = 433 \text{ MHz}$ ;  $f_2 = 434 \text{ MHz}$
- (2)  $f_1 = 900 \text{ MHz}$ ;  $f_2 = 901 \text{ MHz}$
- (3)  $f_1 = 1800 \text{ MHz}$ ;  $f_2 = 1801 \text{ MHz}$

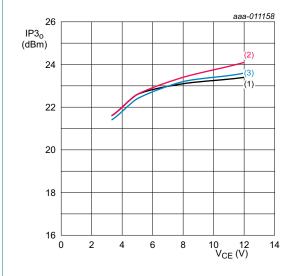
Fig 18. Output third-order intercept point as a function of collector current; typical values



 $V_{CE}$  = 8 V;  $T_{amb}$  = 25 °C.

- (1) f = 433 MHz
- (2) f = 900 MHz
- (3) f = 1800 MHz

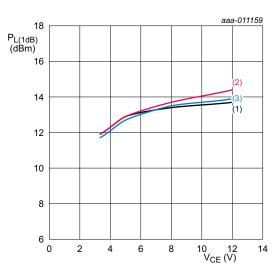
Fig 19. Output power at 1 dB gain compression as a function of collector current; typical values



 $I_C = 25 \text{ mA}; T_{amb} = 25 \text{ °C}.$ 

- (1)  $f_1 = 433 \text{ MHz}$ ;  $f_2 = 434 \text{ MHz}$
- (2)  $f_1 = 900 \text{ MHz}$ ;  $f_2 = 901 \text{ MHz}$
- (3)  $f_1 = 1800 \text{ MHz}$ ;  $f_2 = 1801 \text{ MHz}$

Fig 20. Output third-order intercept point as a function of collector-emitter voltage; typical values

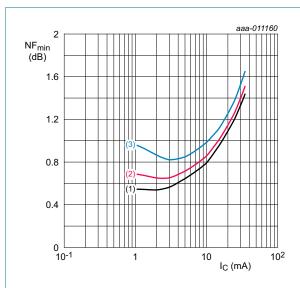


 $I_C = 25 \text{ mA}; T_{amb} = 25 \, ^{\circ}\text{C}.$ 

- (1) f = 433 MHz
- (2) f = 900 MHz
- (3) f = 1800 MHz

Fig 21. Output power at 1 dB gain compression as a function of collector-emitter voltage; typical values

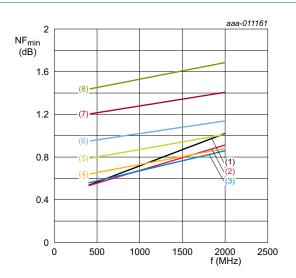
#### NPN wideband silicon RF transistor



$$V_{CE}$$
 = 8 V;  $T_{amb}$  = 25 °C;  $\Gamma_{S}$  =  $\Gamma_{opt}$ .

- (1) f = 433 MHz
- (2) f = 900 MHz
- (3) f = 1800 MHz

Fig 22. Minimum noise figure as a function of collector current; typical values

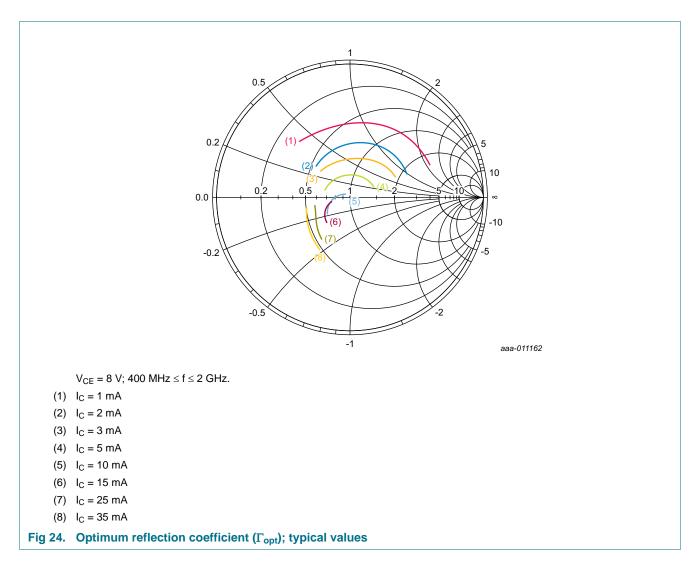


$$V_{CE}$$
 = 8 V;  $T_{amb}$  = 25 °C;  $\Gamma_{S}$  =  $\Gamma_{opt}$ .

- (1)  $I_C = 1 \text{ mA}$
- (2)  $I_C = 2 \text{ mA}$
- (3)  $I_C = 3 \text{ mA}$
- (4)  $I_C = 5 \text{ mA}$
- (5)  $I_C = 10 \text{ mA}$ (6)  $I_C = 15 \text{ mA}$
- (7)  $I_C = 25 \text{ mA}$
- (8)  $I_C = 35 \text{ mA}$

Fig 23. Minimum noise figure as a function of frequency; typical values

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# 10. Application information

More information about the following application example can be found in the application notes. See Section 5 "Design support".

The following application example can be implemented using the evaluation kit. See Section 3 "Ordering information" for the order type number.

The following application example can be simulated using the simulation package. See Section 5 "Design support".

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## 10.1 Application example: 433 ISM band LNA

433 ISM band LNA, optimized for low noise.

More detailed information of the application example can be found in the application note: *AN11381*.

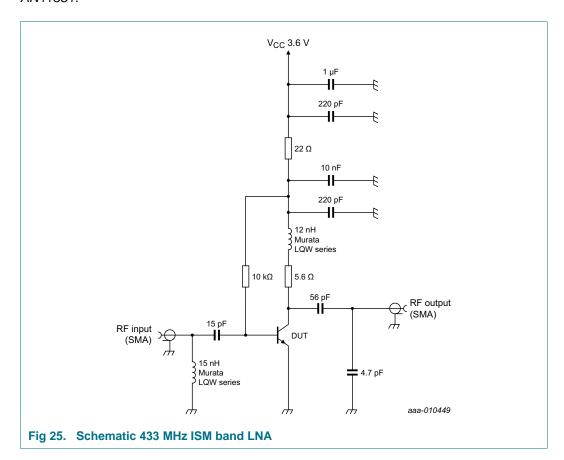


Table 10. Application performance data at 433 MHz  $I_{CC}$  = 20 mA;  $V_{CC}$  = 3.6 V

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$ s_{21} ^2$	insertion power gain		-	19	-	dB
NF	noise figure		-	1.3	-	dB
IP3 <sub>o</sub>	output third-order intercept point	$f_1 = 433.1 \text{ MHz}; f_2 = 433.2 \text{ MHz};$ $P_i = -30 \text{ dBm per carrier}$	-	19	-	dBm

#### NPN wideband silicon RF transistor

## 10.2 Application example: 866 ISM band LNA

866 ISM band LNA, optimized for low noise.

More detailed information of the application example can be found in the application note: *AN11382*.

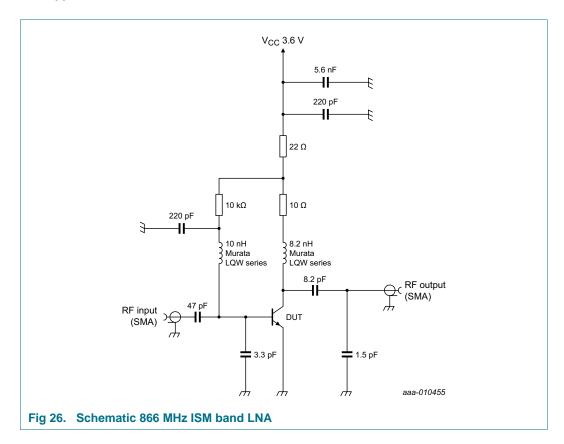


Table 11. Application performance data at 866 MHz

 $I_{CC} = 20 \text{ mA}; V_{CC} = 3.6 \text{ V}$ 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$ s_{21} ^2$	insertion power gain		-	13	-	dB
NF	noise figure		-	1.4	-	dB
IP3 <sub>o</sub>	output third-order intercept point	$f_1 = 866.1 \text{ MHz}; f_2 = 866.2 \text{ MHz};$ $P_i = -30 \text{ dBm per carrier}$	-	19	-	dBm

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# 11. Package outline

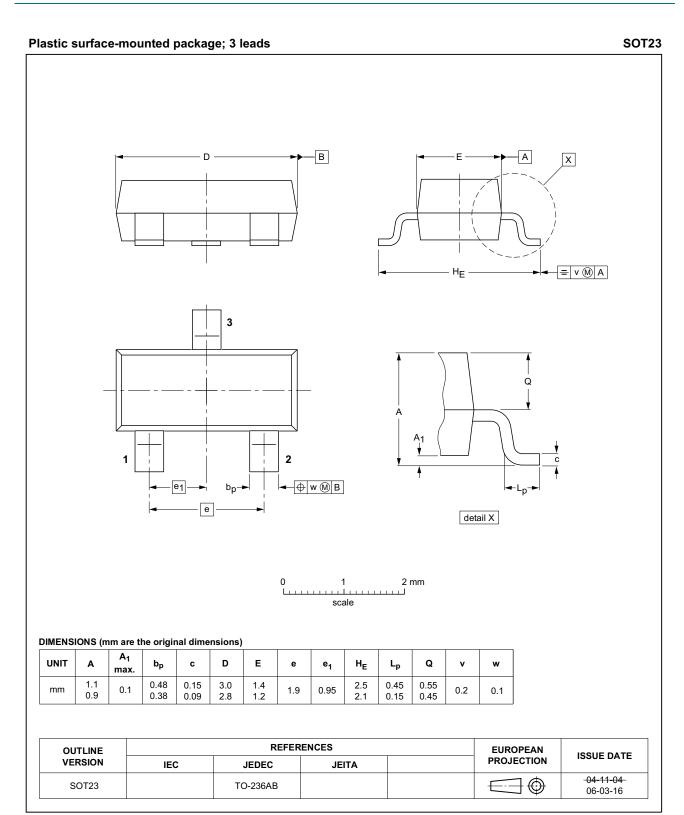


Fig 27. Package outline SOT23

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#### NPN wideband silicon RF transistor

# 12. Handling information

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the ANSI/ESD S20.20, IEC/ST 61340-5, JESD625-A or equivalent standards.

## 13. Abbreviations

Table 12. Abbreviations

Acronym	Description
AEC	Automotive Electronics Council
ISM	Industrial, Scientific and Medical
LNA	Low-Noise Amplifier
MSG	Maximum Stable Gain
NPN	Negative-Positive-Negative
SMA	SubMiniature version A

# 14. Revision history

### Table 13. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU550A v.1	20140113	Product data sheet	-	-

#### NPN wideband silicon RF transistor

## 15. Legal information

#### 15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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